

Si88x2x Data Sheet

Dual Digital Isolators with DC-DC Converter

The Si88xx integrates Silicon Labs' proven digital isolator technology with an on-chip isolated dc-dc converter that provides regulated output voltages of 3.3 or 5.0 V (or >5 V with external components) at peak output power levels of up to 5 W. These devices provide up to two digital channels. The dc-dc converter has user-adjustable frequency for minimizing emissions, a soft-start function for safety, a shutdown option and loop compensation. The device requires only minimal passive components and a miniature transformer.

The ultra-low-power digital isolation channels offer substantial data rate, propagation delay, size and reliability advantages over legacy isolation technologies. Data rates up to 100 Mbps max are supported, and all devices achieve propagation delays of only 23 ns max. Ordering options include a choice of dc-dc converter features, isolation channel configurations and a fail-safe mode. All products are certified by UL, CSA, VDE, and CQC.

Applications:

- · Industrial automation systems
- · Hybrid electric and electric vehicles
- Isolated power supplies
- Inverters

Safety Approval (Pending):

- · UL 1577 recognized
 - · Up to 5000 Vrms for 1 minute
- CSA component notice 5A approval • IEC 60950

- · Data acquisition
- · Motor control
- · PLCs, distributed control systems
- · VDE certification conformity • VDE0884-10
- CQC certification approval
 - GB4943.1

KEY FEATURES

- · High-speed isolators with integrated dc-dc converter
- Fully-integrated secondary sensing feedback-controlled converter with dithering for low EMI
- dc-dc converter peak efficiency of 83% with external power switch
- Up to 5 W isolated power with external power switch
- Options include dc-dc shutdown, frequency control, and soft start
- Standard Voltage Conversion
 - 3/5 V to isolated 3/5 V
 - 24 V to isolated 3/5 V
 - 3/5 V to isolated 24 V
 - 24 V to isolated 24 V
- · Precise timing on digital isolators
 - 0 100 Mbps
 - 18 ns typical prop delay
- · Highly-reliable: 100 year lifetime
- · High electromagnetic immunity and ultralow emissions
- · RoHS compliant packages
 - · SOIC-20 wide body
 - · SOIC-16 wide body
- · Isolation of up to 5000 Vrms
- High transient immunity of 100 kV/µs (typical)
- AEC-Q100 qualified
- · Wide temp range
- –40 to +125 °C

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1. Features List

- High-speed isolators with integrated dc-dc converter
- Fully-integrated secondary sensing feedback-controlled converter with dithering for low EMI
- dc-dc converter peak efficiency of 83% with external power switch
- · Up to 5 W isolated power with external power switch
- Options include dc-dc shutdown, frequency control, and soft start
- Standard Voltage Conversion
 - 3/5 V to isolated 3/5 V
 - 24 V to isolated 3/5 V
 - 3/5 V to isolated 24 V
 - · 24 V to isolated 24 V
- Precise timing on digital isolators
 - 0-100 Mbps
 - 18 ns typical prop delay

- Highly-reliable: 100 year lifetime
- High electromagnetic immunity and ultra-low emissions
- RoHS compliant packages
 - SOIC-20 wide body
 - SOIC-16 wide body
- Isolation of up to 5000 Vrms
- High transient immunity of 100 kV/µs (typical)
- AEC-Q100 qualified
- Wide temp range
 - –40 to +125 °C

2. Ordering Guide

Table 2.1.	Si88x2x	Ordering	Guide ^{1,2,3,4}
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Ordering Part Number	DC-DC Shutdown	Soft Start	Frequency Control	External Switch	Forward Digital	Reverse Digital	Insulation Rating (kVrms)	Package
Available Now								
Si88220BC-IS	Y	Ν	N	N	2	0	3.75	WB SOIC-16
Si88221BC-IS	Y	Ν	N	N	1	1	3.75	WB SOIC-16
Si88222BC-IS	Y	Ν	N	N	0	2	3.75	WB SOIC-16
Si88320BC-IS	Y	Y	Y	N	2	0	3.75	WB SOIC-20
Si88321BC-IS	Y	Y	Y	N	1	1	3.75	WB SOIC-20
Si88322BC-IS	Y	Y	Y	N	0	2	3.75	WB SOIC-20
Si88420BC-IS	N	Ν	N	Y	2	0	3.75	WB SOIC-16
Si88421BC-IS	N	Ν	N	Y	1	1	3.75	WB SOIC-16
Si88422BC-IS	N	Ν	N	Y	0	2	3.75	WB SOIC-16
Si88620BC-IS	Y	Y	Y	Y	2	0	3.75	WB SOIC-20
Si88621BC-IS	Y	Y	Y	Y	1	1	3.75	WB SOIC-20
Si88622BC-IS	Y	Y	Y	Y	0	2	3.75	WB SOIC-20
Si88220EC-IS	Y	N	N	N	2	0	3.75	WB SOIC-16
Si88221EC-IS	Y	Ν	N	N	1	1	3.75	WB SOIC-16
Si88222EC-IS	Y	Ν	N	N	0	2	3.75	WB SOIC-16
Si88320EC-IS	Y	Y	Y	N	2	0	3.75	WB SOIC-20
Si88321EC-IS	Y	Y	Y	N	1	1	3.75	WB SOIC-20
Si88322EC-IS	Y	Y	Y	N	0	2	3.75	WB SOIC-20
Si88420EC-IS	N	N	N	Y	2	0	3.75	WB SOIC-16
Si88421EC-IS	N	Ν	N	Y	1	1	3.75	WB SOIC-16
Si88422EC-IS	N	Ν	N	Y	0	2	3.75	WB SOIC-16
Si88620EC-IS	Y	Y	Y	Y	2	0	3.75	WB SOIC-20
Si88621EC-IS	Y	Y	Y	Y	1	1	3.75	WB SOIC-20
Si88622EC-IS	Y	Y	Y	Y	0	2	3.75	WB SOIC-20
Sampling Now			I	1	1			
Si88220BD-IS	Y	Ν	N	N	2	0	5.0	WB SOIC-16
Si88221BD-IS	Y	Ν	N	N	1	1	5.0	WB SOIC-16
Si88222BD-IS	Y	Ν	N	N	0	2	5.0	WB SOIC-16
Si88320BD-IS	Y	Y	Y	N	2	0	5.0	WB SOIC-20
Si88321BD-IS	Y	Y	Y	N	1	1	5.0	WB SOIC-20
Si88322BD-IS	Y	Y	Y	N	0	2	5.0	WB SOIC-20

Ordering Part Number	DC-DC Shutdown	Soft Start	Frequency Control	External Switch	Forward Digital	Reverse Digital	Insulation Rating (kVrms)	Package
Si88420BD-IS	N	Ν	N	Y	2	0	5.0	WB SOIC-16
Si88421BD-IS	N	N	N	Y	1	1	5.0	WB SOIC-16
Si88422BD-IS	N	N	N	Y	0	2	5.0	WB SOIC-16
Si88620BD-IS	Y	Y	Y	Y	2	0	5.0	WB SOIC-20
Si88621BD-IS	Y	Y	Y	Y	1	1	5.0	WB SOIC-20
Si88622BD-IS	Y	Y	Y	Y	0	2	5.0	WB SOIC-20
Si88220ED-IS	Y	N	N	N	2	0	5.0	WB SOIC-16
Si88221ED-IS	Y	N	N	N	1	1	5.0	WB SOIC-16
Si88222ED-IS	Y	N	N	N	0	2	5.0	WB SOIC-16
Si88320ED-IS	Y	Y	Y	N	2	0	5.0	WB SOIC-20
Si88321ED-IS	Y	Y	Y	N	1	1	5.0	WB SOIC-20
Si88322ED-IS	Y	Y	Y	N	0	2	5.0	WB SOIC-20
Si88420ED-IS	N	N	N	Y	2	0	5.0	WB SOIC-16
Si88421ED-IS	N	N	N	Y	1	1	5.0	WB SOIC-16
Si88422ED-IS	N	N	N	Y	0	2	5.0	WB SOIC-16
Si88620ED-IS	Y	Y	Y	Y	2	0	5.0	WB SOIC-20
Si88621ED-IS	Y	Y	Y	Y	1	1	5.0	WB SOIC-20
Si88622ED-IS	Y	Y	Y	Y	0	2	5.0	WB SOIC-20

Notes:

1. All packages are RoHS-compliant with peak solder reflow temperatures of 260°C according to the JEDEC industry standard classifications.

2. "Si" and "SI" are used interchangeably.

3. AEC-Q100 qualified.

4. All Si88xxxEx product options are default output high on input power loss. All Si88xxxBx product options are default low. See Section 5. Digital Isolator Device Operation for more details about default output behavior.

3. Functional Description

3.1 Theory of Operation

The Si88xx family of products is capable of transmitting and receiving digital data signals from an isolated power domain to a local system power domain with up to 5 kV of isolation. Each part has four unidirectional digital isolation channels. In addition, Si88xx products include an integrated controller and switches for a dc-dc converter which regulates output voltage by sensing it on the isolated side.

3.2 Digital Isolation

The operation of an Si88xx digital channel is analogous to that of a digital buffer, except an RF carrier transmits data across the isolation barrier. This simple architecture provides a robust isolated data path and requires no special considerations or initialization at startup. A simplified block diagram for a single Si88xx channel is shown in Figure 3.1 Simplified Si88xx Channel Diagram on page 7.

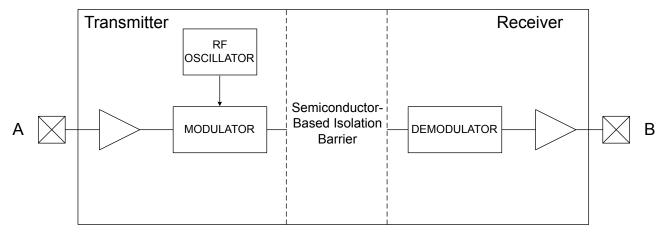


Figure 3.1. Simplified Si88xx Channel Diagram

A channel consists of an RF Transmitter and RF Receiver separated by a silicon dioxide capacitive isolation barrier. In the transmitter, input A modulates the carrier provided by an RF oscillator using on/off keying. The receiver contains a demodulator that decodes the input state according to its RF energy content and applies the result to output B via the output driver. This RF on/off keying scheme is superior to pulse code schemes as it provides best-in-class noise immunity, low power consumption, and better immunity to magnetic fields. See the figure below for more details.

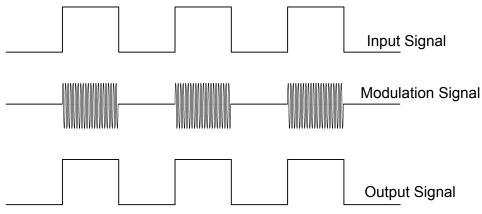


Figure 3.2. Modulation Scheme

3.3 DC-DC Converter Application Information

The Si88xx isolated dc-dc converter is based on a modified fly-back topology and uses an external transformer and Schottky rectifying diode for low cost and high operating efficiency. The PWM controller operates in closed-loop, peak current mode control and generates isolated output voltages with 2 W average output power at 5.0 V. Options are available for up to 24 Vdc input or output operation and externally configured switching frequency.

The dc-dc controller modulates a pair of internal primary-side power switches (see Figure 3.3 Si883xx Block Diagram: 3 V-5 V Input to 3 V-5 V Output on page 10) to generate an isolated voltage at external diode D1 cathode. Closed-loop feedback is provided by a compensated error amplifier, which compares the voltage at the VSNS pin to an internal voltage reference. The resulting error voltage is fed back through the isolation barrier via an internal feedback path to the controller, thus completing the control loop.

For higher input supply voltages than 5 V, an external FET Q2 is modulated by a driver pin ESW as shown in (see Figure 3.5 Si886xx Block Diagram: 24 V Input to 5 V Output on page 12). A shunt resistor based voltage sense pin RSN provides current sensing capability to the controller.

Additional features include an externally-triggered shutdown of the converter functionality using the SH pin and a programmable soft start configured by a capacitor connected to the SS pin. The Si88xx can be used in low- or high-voltage configurations. These features and configurations are explained in more detail below.

3.3.1 Shutdown

This feature allows the operation of the dc-dc converter to be shut down when asserted high. This function is provided by pin 6 (labeled "SH" on the Si882xx) and pin 7 (labeled "SH_FC" on the Si883xx and Si886xx). This feature is not available on the Si884xx. Pin 6 or pin 7 provide the exact same functionality and shut down the dc-dc converter when asserted high. For normal operation, pins 6 and 7 should be connected to ground.

3.3.2 Soft-Start

The dc-dc controller has an internal timer that controls the power conversion start-up to limit inrush current. There is also the Soft Start option where users can program the soft start up by an external capacitor connected to the SS pin. This feature is available on the Si883xx and the Si886xx.

3.3.3 Programmable Frequency

The frequency of the PWM modulator is set to a default of 250 kHz for Si882xx/4xx. Users can program their desired frequency within a given band of 200 kHz to 800 kHz by controlling the time constant of an external RC connected to the SH_FC and SS pins for Si883xx/ 6xx.

3.3.4 External Transformer Driver

The dc-dc controller has internal switches (VSW) for driving the transformer with up-to a 5.5 V voltage supply. For higher voltages on the primary side, a driver output (ESW) is provided that can drive an external NMOS power transistor for driving the transformer. When this configuration is used, a shunt resistor based voltage sense pin (RSN) provides current sensing to the controller.

3.3.5 VREGA, VREGB

For supporting voltages greater than 5.5 V, an internal voltage regulator (VREGA, VREGB) needs to be used in conjunction with an external NPN transistor, a resistor and a capacitor to provide regulated voltage to the IC.

3.3.6 Output Voltage Control

The isolated output voltage (VOUT) is sensed by a resistor divider that provides feedback to the controller through the VSNS pin. The voltage error is encoded and transmitted back to the primary side controller across the isolation barrier, which in turn changes the duty cycle of the transformer driver. The equation for VOUT is as follows:

$$VOUT = VSNS \times \left(1 + \frac{R1}{R2}\right) + R1 \times I_{OFFSET}$$

3.3.7 Compensation

The dc-dc converter uses peak current mode control. The loop is compensated by connecting an external resistor in series with a capacitor from the COMP pin to GNDB. The compensation resistance, RCOMP is fixed at 49.9 k Ω for Si882xx/3xx and 100 k Ω for Si884xx/6xx to match internal resistance. Capacitance value is given by the following equation, where f_C is crossover frequency:

$$CCOMP = \frac{6}{2 \times \pi \times f_C \times RCOMP}$$

For more details on the calculations involved, see AN892: Design Guide for Isolated DC/DC Using the Si882xx/883xx.

3.3.8 Thermal Protection

A thermal shutdown circuit is included to protect the system from over-temperature events. The thermal shutdown is activated at a junction temperature that prevents permanent damage from occurring.

3.3.9 Cycle Skipping

Cycle skipping is included to reduce switching power losses at light loads. This feature is transparent to the user and is activated automatically at light loads. The product options with integrated power switches (Si882xx/3xx) may never experience cycle skipping during operation even at light loads while the external power switch options (Si884xx/6xx) are likely to have cycle skipping start at light loads.

3.3.10 Low-Voltage Configuration

The low-voltage configuration is used for converting 3.0 V to 5.5 V. All product options of the Si882xx and Si883xx are intended for this configuration.

An advantage of Si88xx devices over other converters that use this same topology is that the output voltage is sensed on the secondary side without requiring additional optocouplers and support circuitry to bias those optocouplers. This allows the dc-dc to operate with superior line and load regulation while reducing external components and increasing lifetime reliability.

In a typical digital signal isolation application, the dc-dc powers the Si882xx and Si883xx VDDB as shown in the figure below. In addition to powering the isolated side of the dc-dc, it can deliver up to 2 W of power to external loads. The dc-dc requires an input capacitor, C2, blocking capacitor, C1, transformer, T1, rectifying diode, D1, and an output capacitor, C3. Resistors R1 and R2 divide the output voltage to match the internal reference of the error amplifier. Type 1 loop compensation made by RCOMP and CCOMP are required at the COMP pin. Though it is not necessary for normal operation, we recommend that a snubber be used to minimize radiated emissions. More details can be found in *AN892: Design Guide for Isolated DC-DC Using the Si882xx/883xx*.

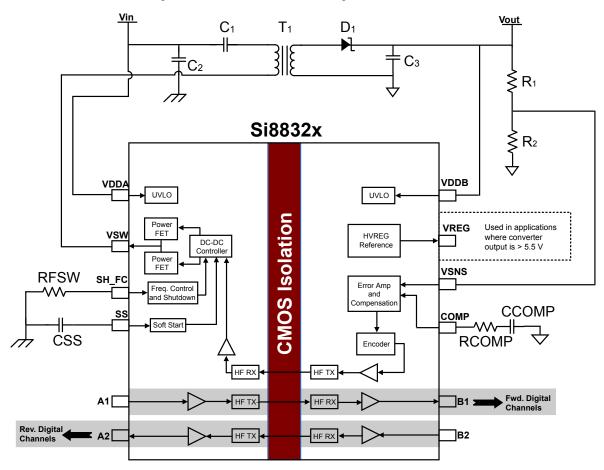


Figure 3.3. Si883xx Block Diagram: 3 V–5 V Input to 3 V–5 V Output

3.3.11 Low-Voltage to High-Voltage Configuration

The low-voltage to high-voltage configuration is used for converting 3.0 V - 5.5 V up to 24 V.

In a typical digital signal isolation application, the dc-dc powers the Si882xx and Si883xx VOUT as shown in the figure below. In addition to powering the isolated side of the dc-dc, it can deliver up to 2 W of power to external loads. The dc-dc requires an input capacitor, C2, blocking capacitor, C1, transformer, T1, rectifying diode, D1, and an output capacitor, C3. Resistors R1 and R2 divide the output voltage to match the internal reference of the error amplifier. To supply VDDB, Q3 transistor is biased and filtered by R5 and C4. Type 1 loop compensation made by RCOMP and CCOMP are required at the COMP pin. Though it is not necessary for normal operation, we recommend that a snubber be used to minimize radiated emissions. More details can be found in *AN892: Design Guide for Isolated DC-DC Using the Si882xx/883xx*.

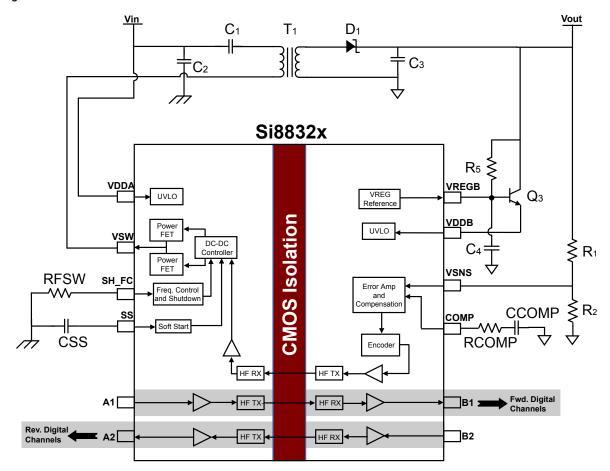


Figure 3.4. Si883xx Block Diagram: 3 V – 5 V Input to up to 24 V Output

3.3.12 High-Voltage to Low-Voltage Configuration

The high-voltage configuration is used for converting up to 24 V to 3.3 V or 5.0 V. All product options of the Si884xx and Si886xx are intended for this configuration.

Si884xx and Si886xx can be used for dc-dc applications that have primary side voltage greater than 5.5 V. The dc-dc converter uses the isolated flyback topology. With this topology, the switch and sense resistor are external, allowing higher switching voltages. Digital isolator supply VDDA of the Si884xx and Si886xx require a supply less than or equal to 5.5 V. If a suitable supply is not available on the primary side, the VREGA voltage reference with external NPN transistor can supply VDDA. This eliminates the need to design an additional linear regulator circuit. Like the Si882xx and Si883xx, the output voltage is sensed on the secondary side without requiring additional optocouplers and support circuitry to bias those optocouplers. This allows the dc-dc to operate with superior line and load regulation.

The figure below shows the block diagram of an Si886xx with external components. Si886xx is different from the Si882xx/883xx as it has externally-controlled switching frequency and soft start. The dc-dc requires input capacitor C2, transformer T1, switch Q1, sense resistor R4, rectifying diode D1 and an output capacitor C3. To supply VDDA, Q2 transistor is biased and filtered by R3 and C1. External frequency and soft start behavior is set by CSS and RFSW. Resistors R1 and R2 divide the output voltage to match the internal reference of the error amplifier. Type 1 loop compensation made by RCOMP and CCOMP are required at the COMP pin. Though it is not necessary for normal operation, we recommend to use a snubber, to minimize high-frequency emissions. For further details, see *AN901: Design Guide for Isolated DC-DC Using the Si884xx/886xx*.

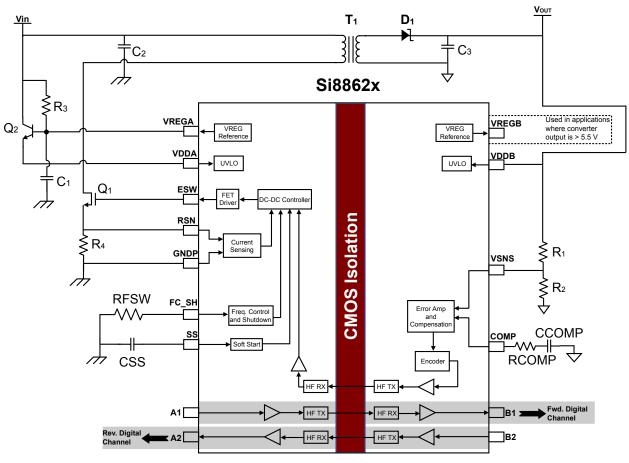


Figure 3.5. Si886xx Block Diagram: 24 V Input to 5 V Output

3.3.13 High-Voltage to High-Voltage Configuration

The high-voltage configuration is used for converting up to 24 V to up to 24 V.

Si884xx and Si886xx can be used for dc-dc applications that have primary side voltage greater than 5.5 V. The dcdc converter uses the isolated flyback topology. With this topology, the switch and sense resistor are external, allowing higher switching voltages. Digital isolator supply VDDA of the Si884xx and Si886xx require a supply less than or equal to 5.5 V. If a suitable supply is not available on the primary side, the VREGA voltage reference with external NPN transistor can supply VDDA. This eliminates the need to design an additional linear regulator circuit. Like the Si882xx and Si883xx, the output voltage is sensed on the secondary side without requiring additional optocouplers and support circuitry to bias those optocouplers. This allows the dc-dc to operate with superior line and load regulation.

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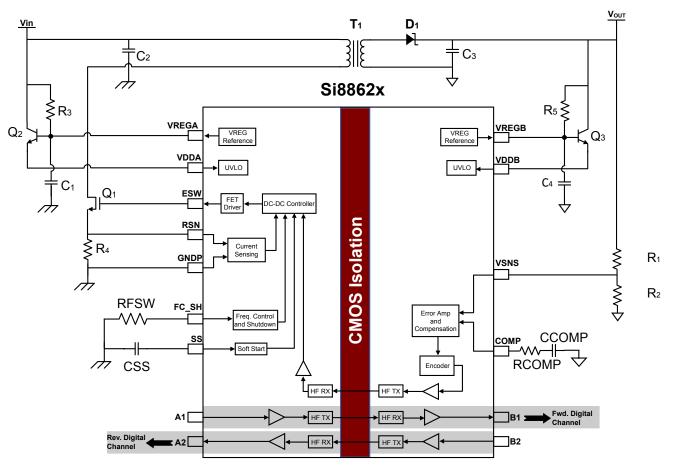


Figure 3.6. Si886xx Block Diagram: Up to 24 V Input to up to 24 V Output

3.4 Transformer Design

The table below provides a list of transformers and their parametric characteristics that have been validated to work with Si882xx/3xx products (input voltage of 3 to 5 V) and Si884xx/Si886xx products (input voltage of 24 V). It is recommended that users order the transformers from the vendors per the part numbers given below. Refer to *AN892: Design Guide for Isolated DC/DC using the Si882xx/*883xx and *AN901: Design Guide for Isolated DC/DC using the Si884xx/*886xx for voltage translation applications not listed below.

To manufacture transformers from your preferred suppliers that may not be listed below, please specify to supplier the parametric characteristics as specified in the table below for a given input voltage and isolation rating.

Transformer Supplier	Ordering Part #	Input Voltage	Output Voltage	Turns Ratio P:S	Leakage Inductance	Primary Inductance	Primary Resistance	Isolation Rating
UMEC (http:// www.umec- usa.com)	UTB02185s	4.5 – 5.5 V	3.0 – 5.5V	1.0:4.0	100 nH max	2 µH ± 5%	0.05 Ω max	2.5 kV _{RMS}
UMEC (http:// www.umec- usa.com)	UTB02205s	12V, 24V	3.3 – 5.0V, 15V	3.0:1.0	800 nH max	25 µH ± 5%	0.135 Ω max	2.5 kV _{RMS}
UMEC (http:// www.umec- usa.com)	UTB02240s	4.5 – 5.5V	3.0 – 5.5V	1.0:4.0	100 nH max	2 µH ±5%	0.05 Ω max	5 kV _{RMS}
UMEC (http:// www.umec- usa.com)	UTB02250s	7 – 24 V	3.3 – 5.5V	3.0:1.0	600 nH max	25 μH ± 5%	0.135 Ω max	5 kV _{RMS}
Coilcraft ¹ (http:// www.coil- craft.com)	TA7608-AL	4.5 – 5.5 V	3.0 – 5.5V	1.0:4.0	60 nH max	2 µH ± 5%	0.033 Ω max	2.5 kV _{RMS}
Coilcraft ¹ (http:// www.coil- craft.com)	TA7618-AL	4.5 – 5.5V	3.0 – 5.5V	1.0:4.0	64 nH max	2.0 μH ±5%	0.031 Ω max	5 kV _{RMS}
Coilcraft ¹ (http:// www.coil- craft.com)	TA7788-AL	12V	5V, 15V	1.00 : 1.25 : 0.75	554 nH max	25 μH ±5%	0.49 Ω max	5 kV _{RMS}
Coilcraft ¹ (http:// www.coil- craft.com)	UA7902	12V	5V, 15V	3.0:1.0	971 nH max	25 μH ±5%	0.075 Ω max	5 kV _{RMS}
TDK (http:// www.tdk.com)	P100940_A1	4.5 – 5.5V	3.0 – 5.5V	1.0:4.0	40 nH max	2.0 µH ±10%	0.1 Ω max	2.4 kV _{RMS}
Mentech ¹ (http:// www.mnc- tek.com)	TTER09-0457S1	8 - 24 V	15V, 24V	1.0:1.0	550 nH max	25 µH ±10%	0.4 Ω max	2.5 kV _{RMS}
Mentech ¹ (http:// www.mnc- tek.com)	TTER09-0458S1	8 - 24 V	8 - 24 V	1.0:1.0	550 nH max	25 µH ±10%	0.4 Ω max	5 kV _{RMS}

Table 3.1. Transformer Specifications

Transformer Supplier	Ordering Part #	Input Voltage	Output Voltage	Turns Ratio P:S	Leakage Inductance	Primary Inductance	Primary Resistance	lsolation Rating
Mentech ¹ (http:// www.mnc- tek.com)	TTEP09-0568S1	3.0 - 5.5 V	5.0 V	1.0:4.0	100 nH max	1.5 μH ±8%	0.05 Ω max	5 kV _{RMS}
Pulse (http:// www.pulsee- lectron- ics.com/)	PA4896NL	8 – 24 V	7 – 24 V	1.0:1.0	650 nH max	25 µH ±10%	0.25 Ω max	2.5 kV _{RMS}
Pulse (http:// www.pulsee- lectron- ics.com/)	PA4897NL	8 – 24 V	7 – 24 V	1.0:1.0	650 nH max	25 µH ±10%	0.25 Ω max	5 kV _{RMS}

Notes:

1. AEC-Q200 qualified.

2. For reference design details, see AN892: Design Guide for Isolated DC/DC using the Si882xx/883xx or AN901: Design Guide for Isolated DC/DC using the Si884xx/886xx.

4. Electrical Specifications

Table 4.1. Recommended Operating Conditions

Parameter	Symbol	Min	Тур	Мах	Unit
Ambient Operating Temperature	T _A	-40	25	125	°C
Power Input Voltage	VDDP	3.0	_	5.5	V
Supply Voltage	VDDA	3.0	_	5.5	V
	VDDB	3.0	_	5.5	V

Table 4.2. Electrical Characteristics¹

 V_{IN} = 24 V; V_{DDA} = V_{DDP} = 3.0 to 5.5 V (see Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23) for all Si8822x/32x; V_{DDA} = 4.3 V (see Figure 4.3 Measurement Circuit for Converter Efficiency and Regulation for Si884xx, Si886xx on page 23) for all Si8842x/62x; T_A = -40 to 125 °C unless otherwise noted.

Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
DC/DC Converter	l					
Switching Frequency Si8822x, Si8842x	FSW	_	225	250	275	kHz
Switching Frequency Si8832x, Si8862x		$R_{FSW} = 23.3 \text{ k}\Omega$ $FSW = 1025.5/(RFSW \times CSS)$ $CSS = 220 \text{ nF}$ (see Figure 3.5 Si886xx Block Diagram: 24 V Input to 5 V Output on page 12) (1% tolerance on BOM)	180	200	220	kHz
	FSW	R _{FSW} = 9.3 kΩ FSW = 1025.5/(RFSW x CSS) CSS = 220 nF (see Figure 3.5 Si886xx Block Diagram: 24 V Input to 5 V Output on page 12) (1% tolerance on BOM)	450	500	550	kHz
		R _{FSW} = 5.18 kΩ, CSS = 220 nF (see Figure 3.5 Si886xx Block Diagram: 24 V Input to 5 V Output on page 12)	810	900	990	kHz
VSNS voltage	VSNS		1.002	1.05	1.097	V
VSNS current offset	I _{offset}	ILOAD = 0 A	-500	—	500	nA
Output Voltage Accuracy ²	_	See Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23 ILOAD = 0 mA	-5	_	+5	%

Parameter	Symbol	Test Condition	Min	Тур	Мах	Unit
Line Regulation	ΔVOUT(line)/ ΔVDDP	See Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23 ILOAD = 50 mA	_	1	_	mV/V
		VDDP varies from 4.5 to 5.5 V				
Load Regulation	ΔVOUT(load)/ VOUT	See Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23	_	0.1		%
		ILOAD = 50 to 400 mA				
		ILOAD = 100 mA				
Output Voltage Ripple Si8822x, Si8832x	_	See Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23	_	100	_	mV p-p
Si8842x, Si8862x		See Figure 4.3 Measurement Circuit for Converter Efficiency and Regulation for Si884xx, Si886xx on page 23				
Turn-on overshoot	ΔVOUT(start)	See Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23 CIN = COUT = 0.1 µF in parallel with 10 µF, ILOAD = 0 A	_	2	_	%
Continuous Output Current Si8822x, Si8832x 5.0 V to 5.0 V 3.3 V to 3.3 V 3.3 V to 5.0 V 5.0 V to 3.3 V Si8842x, Si8862x 24.0 to 5.0 V 24.0 to 3.3 V	ILOAD(max)	See Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23		400 400 250 550 1000 1500	 	mA
Cycle-by-cycle average current limit Si8822x, Si8832x	ILIM	See Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23 Output short circuited	_	3		А
No Load Supply Current IDDP Si8822x, Si8832x	IDDPQ_DCDC ³	See Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23 VDDP = VDDA = 5 V		30		mA

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
No Load Supply Current IDDA Si8822x, Si8832x	IDDAQ_DCDC ⁴	See Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23	_	5.7	_	mA
		VDDP = VDDA = 5 V				
No Load Supply Current IDDP Si8842x, Si8862x	IDDPQ_DCDC ³	See Figure 4.3 Measurement Circuit for Converter Efficiency and Regulation for Si884xx, Si886xx on page 23		0.8		mA
		VIN = 24 V				
No Load Supply Current IDDA Si8842x, Si8862x	IDDAQ_DCDC4	See Figure 4.3 Measurement Circuit for Converter Efficiency and Regulation for Si884xx, Si886xx on page 23	_	5.8	_	mA
		VIN = 24 V				
Peak Efficiency Si8822x, Si8832x		See Figure 4.2 Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx on page 23	_	78	_	
Si8842x, Si8862x	η	See Figure 4.3 Measurement Circuit for Converter Efficiency and Regulation for Si884xx, Si886xx on page 23	_	83	_	%
		I _{REG} = 600 μA				
Voltage Regulator Reference Voltage Si8842x, Si8862x	VREGA, VREGB	See Figure 5.11 Efficiency vs. Load Current over Tempera- ture (5.0 to 5.0 V) on page 31 for typical I–V curve	—	4.8	_	v
VREG tempco	K _{TVREG}	_	_	-0.43		mV/°C
VREG input current	I _{REG}	_	350	_	950	μA
Soft start time, full load		See Figure 5.16 24 V–5 V VOUT Startup vs.Time, No Load Current on page 32				
Si8822x, Si8842x Si8832x, Si8862x	t _{SST}	through Figure 5.21 5 V–5 V VOUT Startup vs.Time (400 mA Load Current) on page 33 for typical soft start times over load conditions.	_	25 50	_	ms
Restart Delay from fault event	tOTP	_		21		S
Digital Isolator						
VDD Undervoltage Threshold	VDDUV+	VDDA, VDDB rising		2.7		V
VDD Undervoltage Threshold	VDDUV-	VDDA, VDDB falling	_	2.6		V
VDD Undervoltage Hysteresis	VDD _{HYS}	_		100	—	mV
Positive-Going Input Threshold	VT+	All inputs rising		1.67		V
Negative-Going Input Threshold	VT–	All inputs falling		1.23		V
Input Hysteresis	V _{HYS}	_		0.44	_	V
High Level Input Voltage	V _{IH}	_	2.0	_		V
	L				I	

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Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Low Level Input Voltage	V _{IL}	_	_	_	0.8	V
High Level Output Voltage	V _{OH}	I _{OH} = -4 mA	V _{DDA} , V _{DDB} – 0.4	_	_	v
Low Level Output Voltage	V _{OL}	I _{OL} = 4 mA	_	_	0.4	V
Input Leakage Current	١L	_	_		±10	μA
Output Impedance	Z _O	_	_	50	_	Ω
Supply Current, C _{LOAD} = 15 pF						
DC, VDDx = 3.3 V ± 10%						
Si88x20ED						
V _{DDA}	_	All inputs = 0	4.2	7.2	10.2	
V _{DDB}	_	All inputs = 0	2.5	4.5	6.5	
V _{DDA}	_	All inputs = 1	1.8	4.8	7.8	mA
V _{DDB}	_	All inputs = 1	2.0	4.0	6.0	-
Si88x21ED	I I					
V _{DDA}	_	All inputs = 0	2.7	5.7	8.7	
V _{DDB}	_	All inputs = 0	3.9	5.9	7.9	
V _{DDA}	_	All inputs = 1	1.8	4.8	7.8	mA
V _{DDB}	_	All inputs = 1	2.0	4.0	6.0	-
Si88x22ED	11					
V _{DDA}	_	All inputs = 0	0.8	3.8	6.8	
V _{DDB}	_	All inputs = 0	5.3	7.3	9.3	
V _{DDA}	_	All inputs = 1	1.8	4.8	7.8	mA
V _{DDB}	_	All inputs = 1	2.0	4.0	6.0	-
Si88x20BD	11				-	
V _{DDA}	_	All inputs = 0	1.8	4.8	7.8	
V _{DDB}	_	All inputs = 0	2.0	4.0	6.0	-
V _{DDA}	_	All inputs = 1	4.2	7.2	10.2	mA
V _{DDB}	_	All inputs = 1	2.5	4.5	6.5	-
Si88x21BD	<u> </u>					
V _{DDA}		All inputs = 0	1.8	4.8	7.8	
V _{DDB}	_	All inputs = 0	2.0	4.0	6.0	1.
V _{DDA}	_	All inputs = 1	2.7	5.7	8.7	mA
V _{DDB}		All inputs = 1	3.9	5.9	7.9	-

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
V _{DDA}		All inputs = 0	1.8	4.8	7.8	
V _{DDB}	_	All inputs = 0	2.0	4.0	6.0	- mA
V _{DDA}	_	All inputs = 1	0.8	3.8	6.8	
V _{DDB}	_	All inputs = 1	5.3	7.3	9.3	
DC, VDDx = 5 V ± 10%				1	L	
Si88x20ED						
V _{DDA}	_	All inputs = 0	6.5	9.5	12.5	
V _{DDB}	_	All inputs = 0	2.5	4.5	6.5	mA
V _{DDA}	—	All inputs = 1	3.0	6.0	9.0	
V _{DDB}	_	All inputs = 1	2.0	4.0	6.0	
Si88x21ED						
V _{DDA}	—	All inputs = 0	5.0	8.0	11.0	
V _{DDB}	_	All inputs = 0	4.0	6.0	8.0]
V _{DDA}	_	All inputs = 1	3.0	6.0	9.0	mA
V _{DDB}	_	All inputs = 1	2.0	4.0	6.0	
Si88x22ED			1	I		1
V _{DDA}	_	All inputs = 0	3.5	6.5	9.5	- mA
V _{DDB}	_	All inputs = 0	5.5	7.5	9.5	
V _{DDA}	_	All inputs = 1	3.0	6.0	9.0	
V _{DDB}	_	All inputs = 1	2.0	4.0	6.0	
Si88x20BD						
V _{DDA}	—	All inputs = 0	3.0	6.0	9.0	
V _{DDB}	_	All inputs = 0	2.0	4.0	6.0]
V _{DDA}	—	All inputs = 1	6.5	9.5	12.5	mA
V _{DDB}	—	All inputs = 1	2.5	4.5	6.5	
Si88x21BD				1		
V _{DDA}	_	All inputs = 0	3.0	6.0	9.0	
V _{DDB}	_	All inputs = 0	2.0	4.0	6.0	
V _{DDA}	_	All inputs = 1	5.0	8.0	11.0	mA
V _{DDB}	_	All inputs = 1	4.0	6.0	8.0	1
Si88x22BD		1				
V _{DDA}	—	All inputs = 0	3.0	6.0	9.0	
V _{DDB}	_	All inputs = 0	2.0	4.0	6.0	
V _{DDA}		All inputs = 1	3.5	6.5	9.5	mA
V _{DDB}		All inputs = 1	5.5	7.5	9.5	

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Note: For calculating total curren	t, including the dy	namic component, see Calculating	Total Curre	ent Consump	tion.	
Timing Characteristics						
Data Rate	_	_	0	_	100	Mbps
Minimum Pulse Width	_	_	10	_	_	ns
Propagation Delay	tPHL	See Figure 4.1 Propagation Delay Timing for Digital Chan- nels on page 22	12.0	17.0	22.0	ns
		VDDx = 3.3 V				
Propagation Delay	t _{PLH}	See Figure 4.1 Propagation Delay Timing for Digital Chan- nels on page 22	11.0	15.0	20.0	ns
		VDDx = 3.3 V				
Propagation Delay	t _{PHL}	See Figure 4.1 Propagation Delay Timing for Digital Chan- nels on page 22	13.0	18.0	23.0	ns
		VDDx = 5.0 V				
Propagation Delay	t _{PLH}	See Figure 4.1 Propagation Delay Timing for Digital Chan- nels on page 22	10.0	13.0	18.0	ns
		VDDx = 5.0 V				
Pulse Width Distortion t _{PLH} – t _{PHL}	PWD	See Figure 4.1 Propagation Delay Timing for Digital Chan- nels on page 22	_	2.5	5.0	ns
		VDDx = 3.3 V				
Pulse Width Distortion t _{PLH} – t _{PHL}	PWD	See Figure 4.1 Propagation Delay Timing for Digital Chan- nels on page 22	_	4.5	7.0	ns
		VDDx = 5.0 V				
Propagation Delay Skew ⁶	t _{PSK(P-P)}	_	—	3.0	10.0	ns
Channel-Channel Skew	t _{PSK}	_		2.0	4.0	ns
Output Rise Time	t _r	C _L = 15 pF	_	2.5	_	ns
Output Fall Time	t _f	C _L = 15 pF		2.5	—	ns
		V _I = VDDx or 0 V				
Common Mode Transient Immunity	СМТІ	V _{CM} = 1500 V (See Figure 4.4 Common- Mode Transient Immunity Test Circuit on page 24)	40	100	_	kV/µs
Startup Time ⁷	t _{SU}	_		55	_	μs

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Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Notes:						
1. Over recommended operating	conditions as not	ted in Table 4.1 Recommended C	Operating Co	nditions on p	age 16.	
2. VOUT = VSNS x (1 + R1/R2)	+ R1 x I _{offset}					
3. VDDP current needed for dc-o	dc circuits.					
4. VDDA current needed for dc-o	dc circuits.					
the on-chip series termination	resistor and char	iver channel is approximately 50 anel resistance of the output drive e appropriately terminated with c	r FET. Wher	n driving load	ls where tran	
6. tPSK(P-P) is the magnitude o supply voltages, load, and am		propagation delay times measure	ed between o	different units	s operating at	t the same
7. Start-up time is the time perior	d from when the L	JVLO threshold is exceeded to va	alid data at th	ne output.		
I		I				

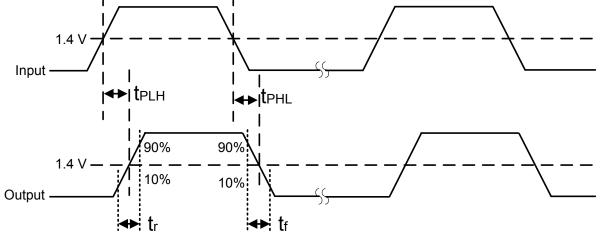


Figure 4.1. Propagation Delay Timing for Digital Channels

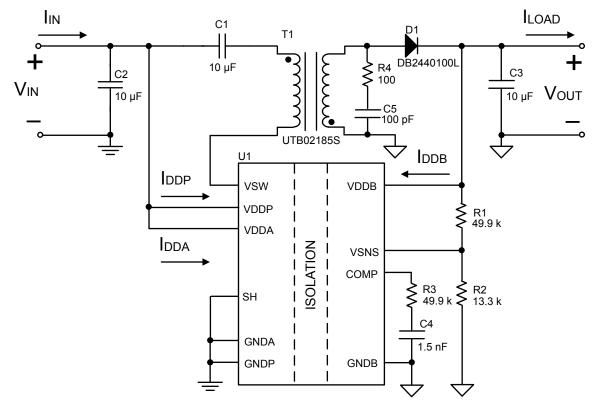


Figure 4.2. Measurement Circuit for Converter Efficiency and Regulation for Si882xx, Si883xx

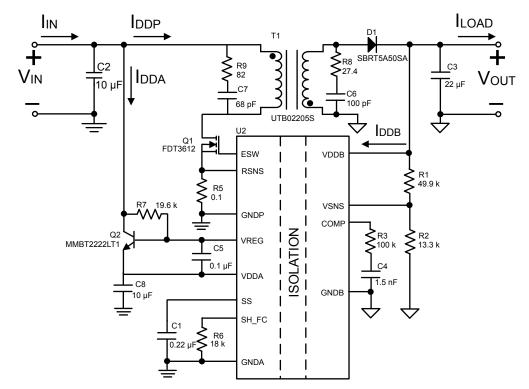


Figure 4.3. Measurement Circuit for Converter Efficiency and Regulation for Si884xx, Si886xx

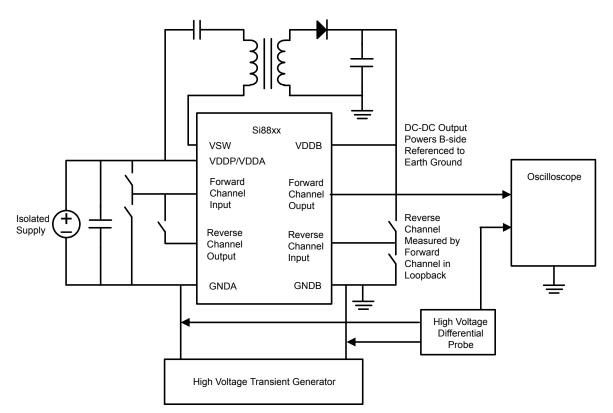


Figure 4.4. Common-Mode Transient Immunity Test Circuit

CSA

The Si88xx is certified under CSA Component Acceptance Notice 5A. For more details, see Master Contract Number 232873.

Rated up to 600 V_{RMS} reinforced insulation working voltage; up to 1000 V_{RMS} basic insulation working voltage.

VDE

The Si88xx is certified according to VDE 0884-10. For more details, see certificate 40018443.

VDE 0884-10: Up to 891 V_{peak} for basic insulation working voltage.

UL

The Si88xx is certified under UL1577 component recognition program. For more details, see File E257455.

Rated up to 5000 V_{RMS} isolation voltage for basic protection.

CQC

The Si88xx is certified under GB4943.1-2011.

Rated up to 600 V_{RMS} reinforced insulation working voltage; up to 1000 V_{RMS} basic insulation working voltage.

Notes:

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1. Regulatory Certifications apply to 3.75 and 5.0 kVrms rated devices, which are production tested to 4.5 and 6.0 kVrms for 1 sec, respectively.

2. All certifications are pending.

Table 4.3. Regulatory Information^{1,2}

Parameter	Symbol	Test Condition	Value	Unit
			WB SOIC-20 WB SOIC-16	
Nominal External Air Gap (Clearance)	CLR		8.0 ¹	mm
Nominal External Tracking (Creepage)	CPG		8.0 ¹	mm
Minimum Internal Gap (Internal Clearance)	DTI		0.014	mm
Tracking Resistance	PTI or CTI	IEC60112	600	V
Erosion Depth	ED		0.019	mm
Resistance (Input-Output) ²	R _{IO}		10 ¹²	Ω
Capacitance (Input-Output) ²	C _{IO}	f = 1 MHz	1.4	pF
Input Capacitance ³	CI		4.0	pF

Table 4.4. Insulation and Safety-Related Specifications

Notes:

1. The values in this table correspond to the nominal creepage and clearance values. VDE certifies the clearance and creepage limits as 8.5 mm minimum for the WB SOIC-20 and WB SOIC-16 packages. UL does not impose a clearance and creepage minimum for component-level certifications. CSA certifies the clearance and creepage limits as 7.6 mm minimum for the WB SOIC-20 and WB SOIC-20 and WB SOIC-16 packages.

2. To determine resistance and capacitance, the Si88xx is converted into a 2-terminal device. Pins 1–8 are shorted together to form the first terminal and pins 9–16 are shorted together to form the second terminal. The parameters are then measured between these two terminals.

3. Measured from input to ground.

Table 4.5. IEC 60664-1 Ratings

Parameter	Test Condition	Specification		
		WB SOIC-20 WB SOIC-16		
Basic Isolation Group	Material Group	I		
Installation Classification	Rate Mains Voltages <150 V _{RMS}	I–IV		
	Rate Mains Voltages <300 V _{RMS}	I–IV		
	Rate Mains Voltages <400 V _{RMS}	I–III		
	Rate Mains Voltages <600 V _{RMS}	I–III		

Parameter Symbol Test Condition		Characteristic	Unit
		WB SOIC-20, WB SOIC-16	
V _{IORM}		891	V peak
V _{PR}	Method b1 (V _{IORM} × 1.875 = V _{PR} , 100% Production Test, t _m = 1 sec, Partial Discharge < 5 pC)	1671	V peak
VIOTM	t = 60 sec	6000	V peak
V _{IOSM}	Tested per IEC 60065 with surge voltage of 1.2 μs/50 μs Tested with 4000 V	3077	V peak
		2	
R _S		>10 ⁹	Ω
	V _{IORM} V _{PR} V _{IOTM}	VIORM VPR Method b1 (VIORM × 1.875 = VPR, 100% Production Test, tm = 1 sec, Partial Discharge < 5 pC)	SymbolTest ConditionWB SOIC-20, V_{IORM} Method b1 ($V_{IORM} \times 1.875 = V_{PR}, 100\%$ Production Test, $t_m = 1 \sec$, Partial Discharge < 5 pC)

Table 4.6. VDE 0884-10 Insulation Characteristics¹

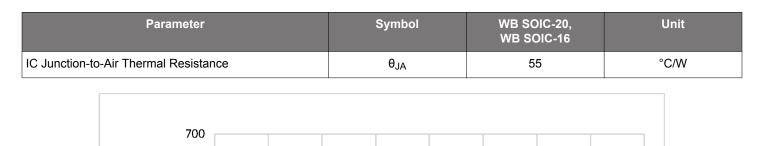
Table 4.7. IEC Safety Limiting Values¹

Parameter	Symbol	Test Condition	WB SOIC-20, WB SOIC-16	Unit
Safety Temperature	T _S		150	°C
Safety Input Current	I _S	$\theta_{JA} = 55 \text{ °C/W}$	413	mA
Device Power Dissipation	P _S	(WB SOIC-20, WB SOIC-16), V _{DDA} = 5.5 V, T _J = 150 °C, T _A = 25 °C	2.27	W

Note:

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1. Maximum value allowed in the event of a failure. Refer to the thermal derating curve in Figure 4.5 WB SOIC-16/20 Thermal Derating Curve Dependence of Safety Limiting Values per VDE 0884-10 on page 27.



631

413

40

600

500

400

300

200

100

0 L 0

20

Safety limit current, mA

3.6V

120

5.5V

140

160

Table 4.8. Thermal Characteristics

Figure 4.5. WB SOIC-16/20 Thermal Derating Curve Dependence of Safety Limiting Values per VDE 0884-10

60

Temperature °C

80

100

Parameter	Symbol	Min	Мах	Unit
Storage Temperature	T _{STG}	-65	+150	°C
Junction Temperature	TJ	—	+150	°C
Input-side Supply Voltage	VDDA	-0.6	6.0	V
	VDDP			
Output supply	VDDB	-0.6	6.0	V
Voltage on any Pin with respect to Ground	VIN	-0.5	VDD + 0.5	V
Output Drive Current per Channel	Ι _Ο		10	mA
Input Current for VREGA, VREGB	I _{REG}	—	1	mA
Lead Solder Temperature (10 s)		—	260	°C
ESD per AEC-Q100	HBM	—	4	kV
	CDM	—	2	kV
Maximum Isolation (Input to Output) (1 sec) WB SOIC-20, WB SOIC-24		-	6500	V _{RMS}
	1	1		

Table 4.9. Absolute Maximum Ratings¹

Notes:

1. Permanent device damage may occur if the absolute maximum ratings are exceeded. Functional operation should be restricted to the conditions as specified in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

4.1 Calculating Total Current Consumption

For calculating dynamic supply current, use the following guidelines:

The dynamic current is calculated as follows:

$$IDD(ac) = (C_L) \times (V) \times (\frac{D}{2}) \times 1E^{-3}$$

Where

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IDD(ac) is the dynamic component of current, per output channel, in mA

D is the data-rate of that channel, in Mbps

CL is the load capacitance connected to the output, in pF

V is the VDD on the output side, in Volts

For example, for the Si88x21ED-IS, the total current can be calculated as follows:

The average DC IDDA/B is the average of the DC current values at input 0 and input 1, for VDDA and VDDB respectively, as stated in the table above for Si88x21ED.

CL, pF	VDD, V	Data-rate, MBps	IDD(ac), per output channel, mA	Total IDDA (ac), mA	Total IDDB (ac), mA	•	Average DC IDDB, mA	Total IDDA, mA	Total IDDB, mA
20.00	5.00	10.00	0.50	0.50	0.50	8.25	6.95	8.75	7.45
20	3.3	100	3.30	3.30	3.30	8.25	6.95	11.55	10.25

5. Digital Isolator Device Operation

VI Input	VDDI ^{1,2,3,4}	VDDO ^{1,2,3,4}	VO Output	Comments
н	Р	Р	н	Normal operation.
L	Р	Р	L	
x	UP	Р	L ⁴ H ⁴	Upon transition of VDDI from unpowered to powered, $V_{\rm O}$ returns to the same state as $V_{\rm I}.$
X	Р	UP	Undetermined	Upon transition of VDDO from unpowered to powered, $V_{\rm O}$ returns to the same state as $V_{\rm I}.$

Table 5.1. Si88xx Logic Operation

Notes:

1. VDDI and VDDO are the input and output power supplies. VI and VO are the respective input and output terminals.

2.P = powered; UP = unpowered.

3. Note that an I/O can power the die for a given side through an internal diode if its source has adequate current. This situation should be avoided. We recommend that I/O's not be driven high when primary side supply is turned off or when in dc-dc shut-down mode.

5.1 Device Startup

Outputs are held low during power up until VDDx is above the UVLO threshold for time period t_{SU}. Following this, the outputs follow the states of inputs.

5.2 Undervoltage Lockout

Undervoltage Lockout (UVLO) is provided to prevent erroneous operation during device startup and shutdown or when VDDx is below its specified operating circuits range. Both Side A and Side B each have their own undervoltage lockout monitors. Each side can enter or exit UVLO independently. For example, Side A unconditionally enters UVLO when VDDA falls below V_{DDUV-} and exits UVLO when VDDA rises above V_{DDUV+} . Side B operates the same as Side A with respect to its VDD supply.

5.3 Layout Recommendations

To ensure safety in the end user application, high voltage circuits (i.e., circuits with >30 V_{AC}) must be physically separated from the safety extra-low voltage circuits (SELV is a circuit with <30 V_{AC}) by a certain distance (creepage/clearance). If a component, such as a digital isolator, straddles this isolation barrier, it must meet those creepage/clearance requirements and also provide a sufficiently large high-voltage breakdown protection rating (commonly referred to as working voltage protection). Table 4.4 Insulation and Safety-Related Specifications on page 25 and Table 4.6 VDE 0884-10 Insulation Characteristics¹ on page 26 detail the working voltage and creepage/clearance capabilities of the Si88xx. These tables also detail the component standards (UL1577, VDE0884-10, CSA 5A), which are readily accepted by certification bodies to provide proof for end-system specifications requirements. Refer to the end-system specification (61010-1, 60950-1, 60601-1, etc.) requirements before starting any design that uses a digital isolator.

5.3.1 Supply Bypass

The Si88xx family requires a 0.1 μ F bypass capacitor between all VDDx and their associated GNDx. The capacitor should be placed as close as possible to the package. To enhance the robustness of a design, the user may also include resistors (50–300 Ω) in series with the inputs and outputs if the system is excessively noisy.

5.3.2 Output Pin Termination

The nominal output impedance of an isolator driver channel is approximately 50 Ω , ±40%, which is a combination of the value of the onchip series termination resistor and channel resistance of the output driver FET. When driving high-impedance terminated PCB traces, output pins should be source-terminated to minimize reflections.

^{4.} See Section 2. Ordering Guide for details. This is the selectable fail-safe operating mode (ordering option). When VDDB is powered via the primary side and the integrated dc-dc, the default outputs are undetermined as secondary side power is not available when primary side power shuts off.

5.4 Fail-Safe Operating Mode

Si88xx devices feature a selectable (by ordering option) mode whereby the default output state (when the input supply is unpowered) can either be a logic high or logic low when the output supply is powered. See Table 5.1 Si88xx Logic Operation on page 29 and Table 2.1 Si88x2x Ordering Guide^{1,2,3,4} on page 5 for more information.

5.5 Typical Performance Characteristics

The typical performance characteristics are for information only. Refer to Table 4.2 Electrical Characteristics¹ on page 16 for specification limits. The data below is for all channels switching.

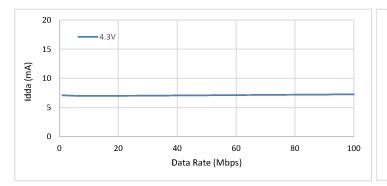


Figure 5.1. Si88620 Typical V_{DDA} Supply Current vs. Data Rate Using VREGA (4.3 V)

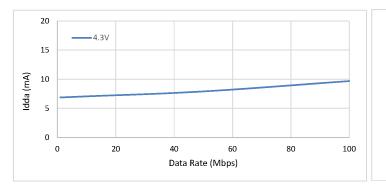


Figure 5.3. Si88621 Typical V_{DDA} Supply Current vs. Data Rate Using VREGA (4.3 V)

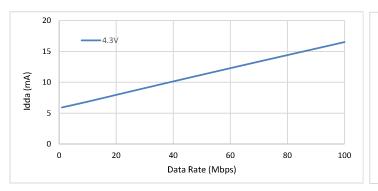


Figure 5.5. Si88622 Typical V_{DDA} Supply Current vs. Data Rate Using VREGA (4.3 V)

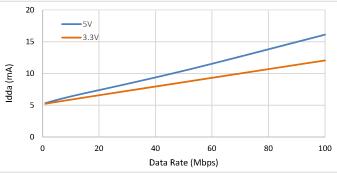


Figure 5.2. Si88620 Typical V_{DDB} Supply Current vs. Data Rate (5 and 3.3 V Operation)

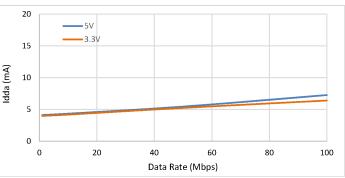


Figure 5.4. Si88621 Typical V_{DDB} Supply Current vs. Data Rate (5 and 3.3 V Operation)

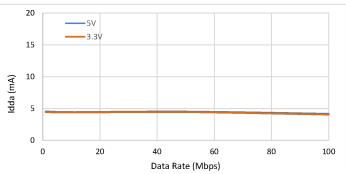


Figure 5.6. Si88622 Typical V_{DDB} Supply Current vs. Data Rate (5 and 3.3 V Operation)

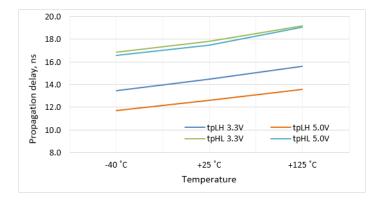


Figure 5.7. Propagation Delay vs. Temperature

80

70

60 50

840

Efficiency

10

0

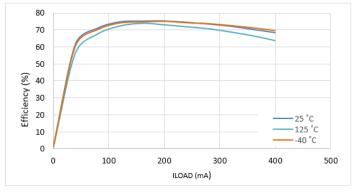


Figure 5.8. Efficiency vs. Load Current over Temperature (3.3 to 3.3 V)

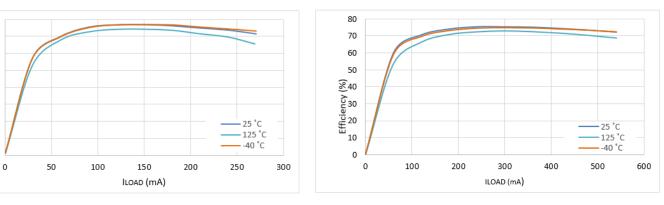


Figure 5.9. Efficiency vs. Load Current over Temperature (3.3 to 5.0 V)

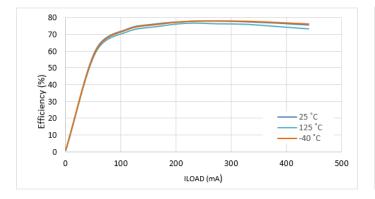


Figure 5.11. Efficiency vs. Load Current over Temperature (5.0 to 5.0 V)

Figure 5.10. Efficiency vs. Load Current over Temperature (5.0 to 3.3 V)

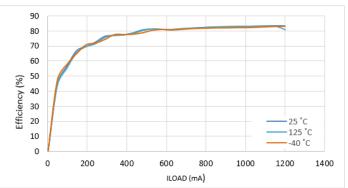


Figure 5.12. Efficiency vs. Load Current over Temperature (24 V to 5 V)

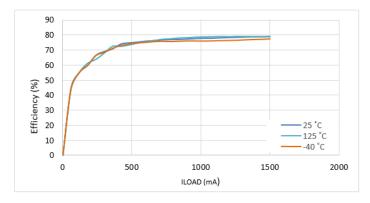


Figure 5.13. Efficiency vs. Load Current over Temperature (24 V to 3.3 V)

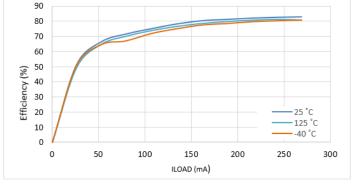


Figure 5.14. Efficiency vs. Load Current over Temperature (12 V to 5 V)

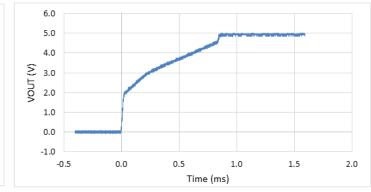


Figure 5.16. 24 V–5 V VOUT Startup vs.Time, No Load Current

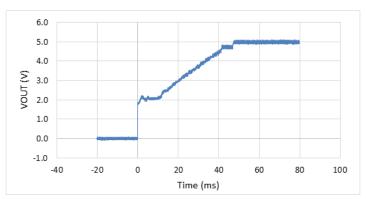


Figure 5.18. 24 V–5 V VOUT Startup vs.Time, 400 mA Load Current

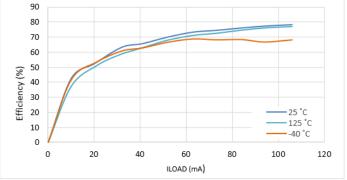


Figure 5.15. Efficiency vs. Load Current over Temperature (7 V to 24 V)

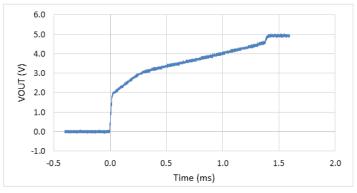


Figure 5.17. 24 V–5 V VOUT Startup vs.Time, 50 mA Load Current

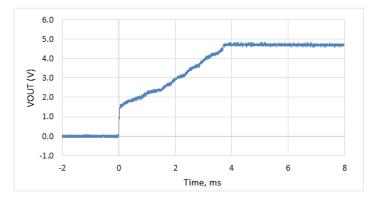


Figure 5.19. 5 V–5 V VOUT Startup vs.Time (No Load)

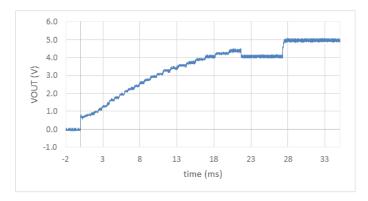


Figure 5.21. 5 V–5 V VOUT Startup vs.Time (400 mA Load Current)

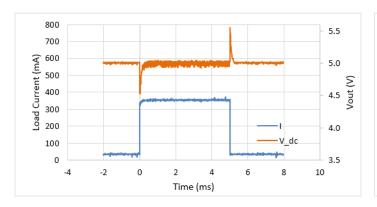


Figure 5.23. 5 V–5 V VOUT Load Transient Response (10% to 90% Load)

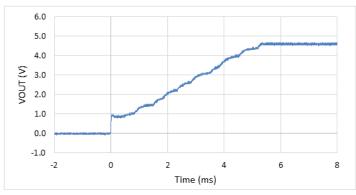


Figure 5.20. 5 V–5 V VOUT Startup vs.Time (50 mA Load Current)

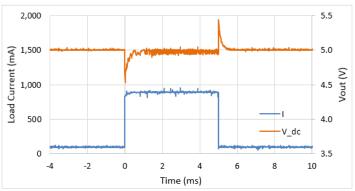


Figure 5.22. 24 V–5 V VOUT Load Transient Response (10% to 90% Load)

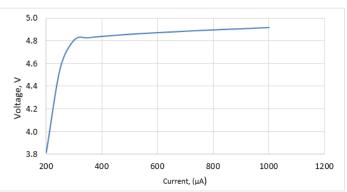


Figure 5.24. Typical I-V Curve for VREGA/B

6. Pin Descriptions

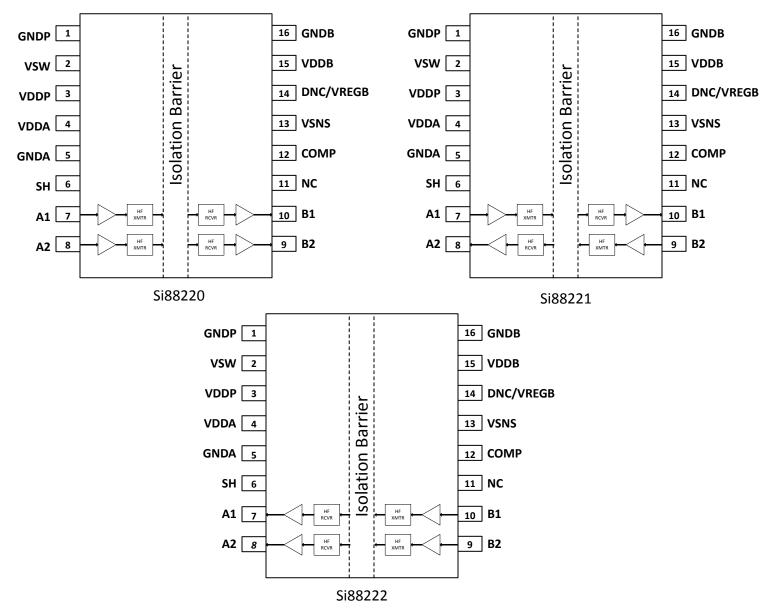


Figure 6.1. Si8822x Pin Configurations

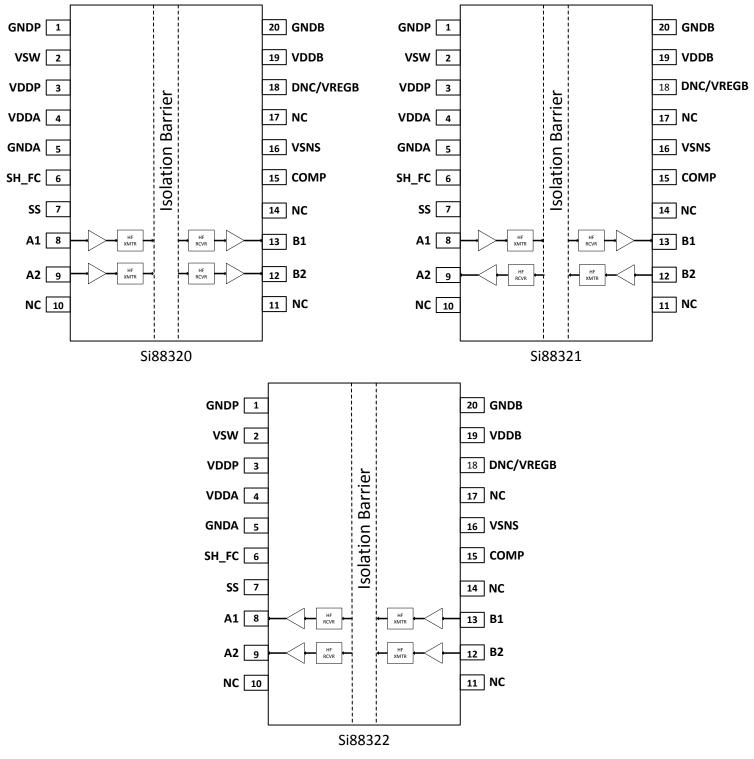
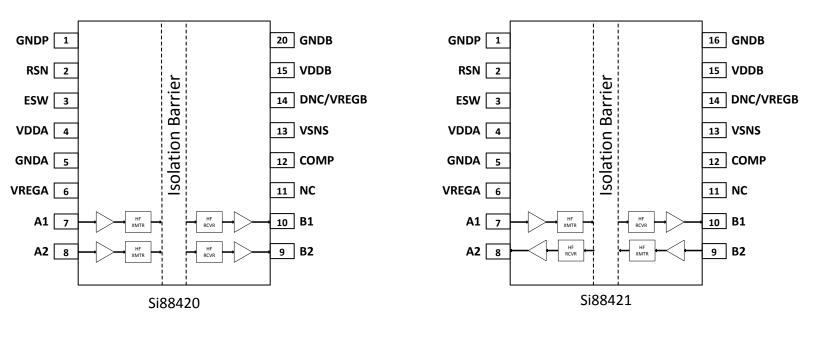


Figure 6.2. Si8832x Pinout Diagrams



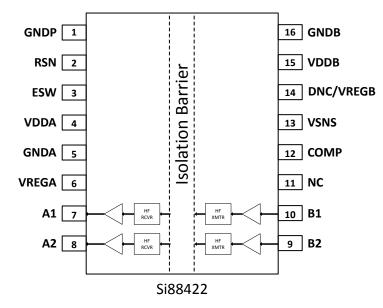


Figure 6.3. Si8842x Pinout Diagrams

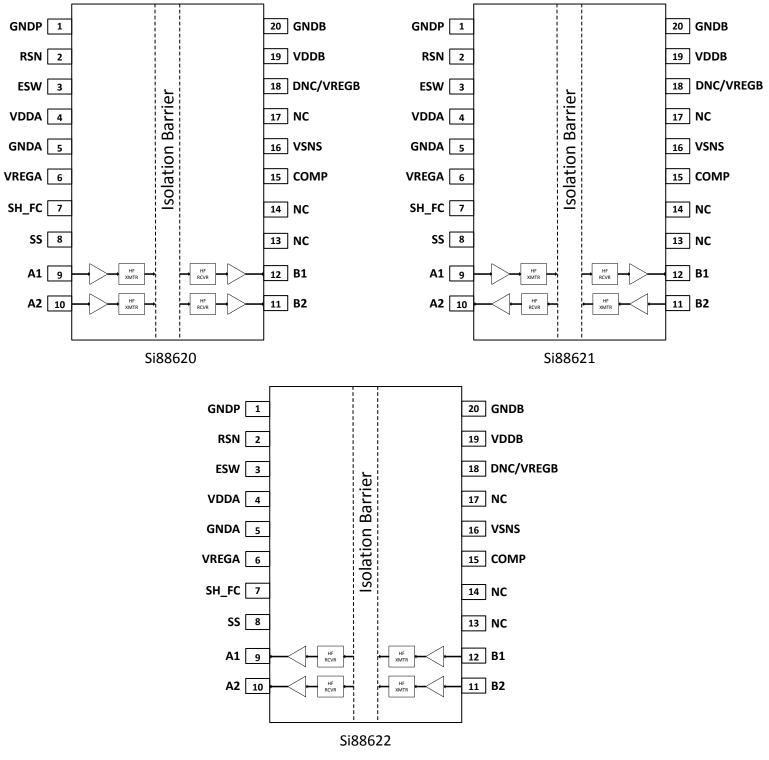


Figure 6.4. Si8862x Pinout Diagrams

Table 6.1. Si88x2x Pin Descriptions

Pin Name	Description	
DC-DC Input Side		
VDDP	Power stage primary power supply.	
VREGA	Voltage reference output for external voltage regulator pin.	
GNDP	Power stage ground.	
ESW	Power stage external switch driver output.	
VSW	Power stage internal switch output.	
SS	Soft startup control.	
SH, SH_FC	Shutdown and Switch frequency control.	
RSN	Power stage current sense input.	
DC-DC Output Side		
VSNS	Power stage feedback input.	
COMP	Power stage compensation.	
DNC/VREGB	Voltage reference output for external voltage regulator pin. This pin has a Zener connected internally. Use this pin as reference only when output voltage from dc-dc is > 5.5 V. If output voltage is ≤ 5.5 V, this pin should be read as DNC or Do Not Connect.	
NC	No connect; this pin is not connected to the silicon.	
Digital Isolator VDDA	Side	
VDDA	Primary side signal power supply.	
A1–A2	I/O signal channel 1–4.	
GNDA	Primary side signal ground.	
Digital Isolator VDDB	Side	
VDDB	Secondary side signal power supply.	
B1–B2	I/O signal channel 1–4.	
GNDB	Secondary side signal ground.	

7. Package Outlines

7.1 Package Outline: 20-Pin Wide Body SOIC

The figure below illustrates the package details for the 20-pin wide-body SOIC package. The table below lists the values for the dimensions shown in the illustration.

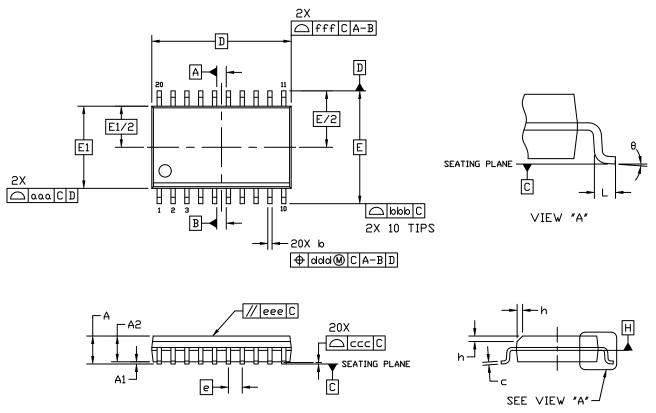


Figure 7.1. 20-Pin Wide Body SOIC

Dimension	Min	Мах
A	_	2.65
A1	0.10	0.30
A2	2.05	_
b	0.31	0.51
С	0.20	0.33
D	12.80	BSC
E	10.30	BSC
E1	7.50 BSC	
е	1.27 BSC	
L	0.40	1.27
h	0.25	0.75
θ	0°	8°
ааа	_	0.10
bbb	_	0.33
CCC	_	0.10
ddd	_	0.25
eee	_	0.10
fff		0.20

Table 7.1. 20-Pin Wide Body SOIC Package Diagram Dimensions

All dimensions shown are in millimeters (mm) unless otherwise noted.
 Dimensioning and Tolerancing per ANSI Y14.5M-1994.

3. This drawing conforms to JEDEC Outline MS-013, Variation AC.

4. Recommended reflow profile per JEDEC J-STD-020C specification for small body, lead-free components.

7.2 Package Outline: 16-Pin Wide Body SOIC

The figure below illustrates the package details for the Si864x Digital Isolator. The table below lists the values for the dimensions shown in the illustration.

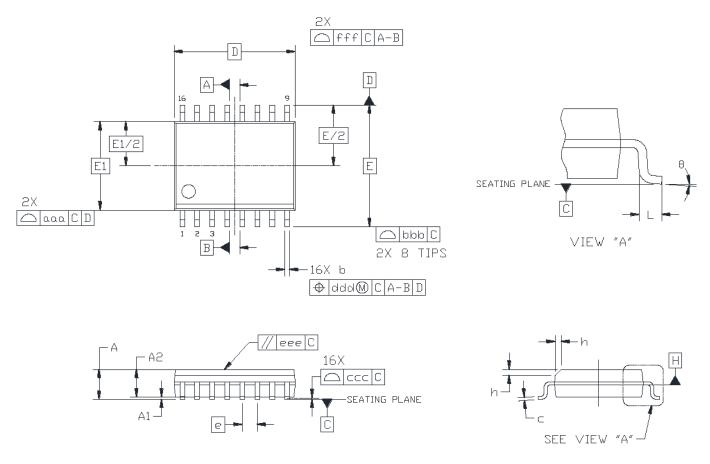


Figure 7.2. 16-Pin Wide Body SOIC

Dimension	Min	Мах
A	—	2.65
A1	0.10	0.30
A2	2.05	—
b	0.31	0.51
с	0.20	0.33
D	10.30	BSC
E	10.30 BSC	
E1	7.50 BSC	
e	1.27 BSC	
L	0.40	1.27
h	0.25	0.75
θ	0°	8°
ааа	—	0.10
bbb	—	0.33
200	—	0.10
ddd	—	0.25
eee	—	0.10
fff	—	0.20
Notes:	· · · · · · · · · · · · · · · · · · ·	

Table 7.2. Package Diagram Dimensions

1. All dimensions shown are in millimeters (mm) unless otherwise noted.

2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

3. This drawing conforms to JEDEC Outline MS-013, Variation AA.

4. Recommended reflow profile per JEDEC J-STD-020 specification for small body, lead-free components.

8. Land Patterns

8.1 Land Pattern: 20-Pin SOIC

The figure below illustrates the PCB land pattern details for the 20-pin SOIC package. The table below lists the values for the dimensions shown in the illustration.

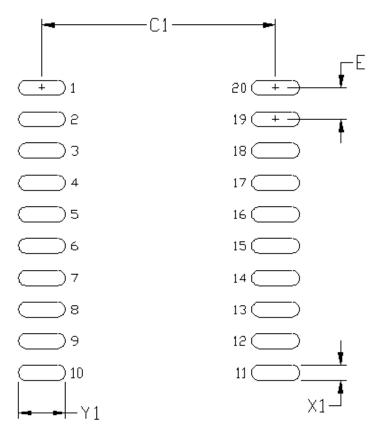


Figure 8.1. 20-Pin SOIC PCB Land Pattern

Table 8.1.	24-Pin SOIC PCB Land Pattern Dimensions
------------	---

Dimension	mm
C1	9.40
E	1.27
X1	0.60
Y1	1.90

Notes:

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1. This Land Pattern Design is based on IPC-7351 design guidelines for Density Level B (Median Land Protrusion).

2. All feature sizes shown are at Maximum Material Condition (MMC), and a card fabrication tolerance of 0.05 mm is assumed.

8.2 Land Pattern: 16-Pin Wide-Body SOIC

The figure below illustrates the recommended land pattern details for the Si864x in a 16-pin wide-body SOIC. The table below lists the values for the dimensions shown in the illustration.

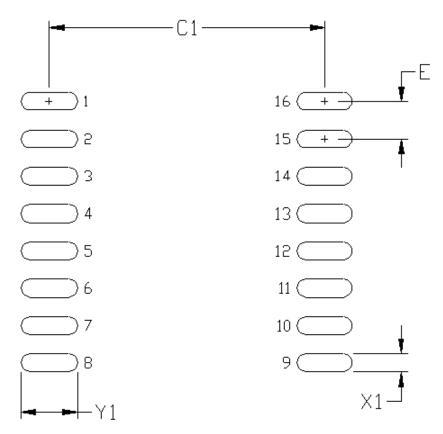


Figure 8.2. 16-Pin SOIC Land Pattern

Table 8.2.	16-Pin Wide Body SOIC Land Pattern Dimensions
------------	---

Dimension	Feature	(mm)
C1	Pad Column Spacing	9.40
E	Pad Row Pitch	1.27
X1	Pad Width	0.60
Y1	Pad Length	1.90
Notes:		1
1. This Land Pattern Design is base	d on IPC-7351 pattern SOIC127P1032X265-16AN for Density	Level B (Median Land Protru-

sion).

2. All feature sizes shown are at Maximum Material Condition (MMC) and a card fabrication tolerance of 0.05 mm is assumed.

9. Top Markings

9.1 Si88x2x Top Marking: 20-Pin Wide Body SOIC



Figure 9.1. 20-Pin Wide Body SOIC

Table 9.1. Top Marking Explanation (20-Pin Wide Body SOIC)

	Base Part Number Ordering Options See 2. Ordering Guide for more information.	Si88x2 = 5 kV rated channel digital isolator with dc-dc converter
		X = 3, 6
		3 = Full-featured dc-dc with integrated FET 6 = full featured dc-dc with external FET
		Y = Number of reverse channels
Line 1 Marking:		Z = E, B
		E = default high B = default low
		R = C, D
		C = 3.75 kVrms isolation rating D = 5 kVrms isolation rating
Line 2 Marking:	YY = Year WW = Workweek	Assigned by the Assembly House. Corresponds to the year and workweek of the mold date.
	TTTTTT = Mfg Code	Manufacturing Code from Assembly Purchase Order form.
Line 3 Marking:	Circle = 1.5 mm Diameter (Center Justified)	"e4" Pb-Free Symbol
	Country of Origin ISO Code Abbreviation	TW = Taiwan

9.2 Si88x2x Top Marking: 16-Pin Wide Body SOIC

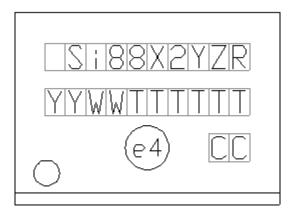


Figure 9.2. 16-Pin Wide Body SOIC

Table 9.2. Top Marking Explanation (16-Pin Wide Body SOIC)

Line 1 Marking:	Base Part Number Ordering Options See 2. Ordering Guide for more information.	Si88x2 = 5kV rated 2 channel digital isolator with dc-dc converter X = 2, 4 2 = dc-dc shutdown
		4 = external FET Y = Number of reverse channels Z = E, B E = default high B = default low R = C, D
	YY = Year WW = Workweek	C = 3.75 kVrms isolation rating D = 5 kVrms isolation rating Assigned by the Assembly House. Corresponds to the year and workweek of the mold date.
	TTTTTT = Mfg Code	Manufacturing Code from Assembly Purchase Order form.
Line 3 Marking:	Circle = 1.5 mm Diameter (Center Justified)	"e4" Pb-Free Symbol
	Country of Origin ISO Code Abbreviation	TW = Taiwan

10. Revision History

Rev. 1.02

March 2019

Corrected Transformer Specification table

Rev. 1.01

November 2018

Updated Transformer Specification table

Rev. 1.0

February 2018

- Updated Ordering Guide Table 2.1
- Updated Transformer Table 3.1
- Updated Spec Table 4.2
- Added section 4.1 (Calculating total current)
- Corrected pin-outs Fig 6.1, 6.3

Rev. 0.6

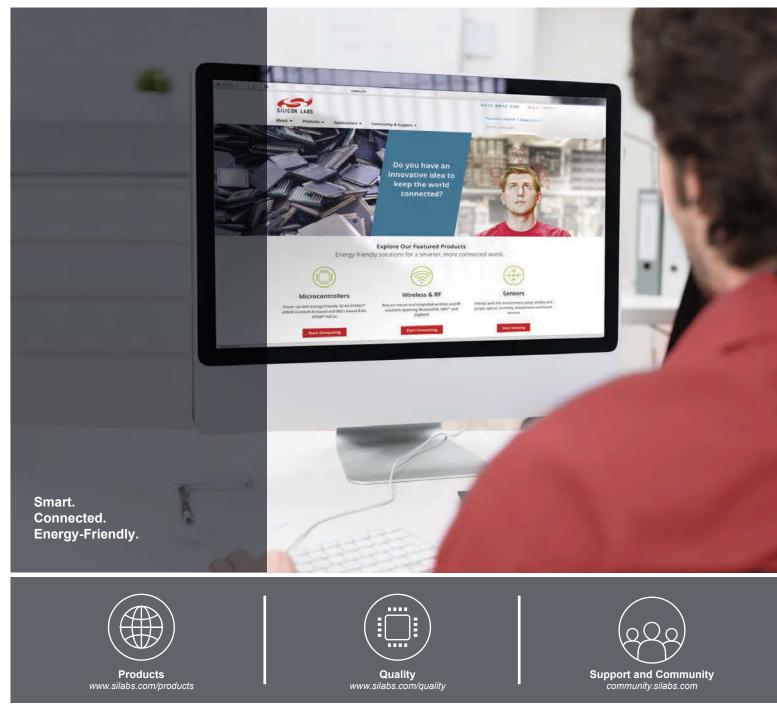
May 11, 2017

- Updated format to current style guide.
- Added WB-SOIC-16 to Table 4.7 IEC Safety Limiting Values¹ on page 26.
- Updated Table 3.1 Transformer Specifications on page 14.
- Updated 5.5 Typical Performance Characteristics.
- Updated pinouts and pin description table in Section 6. Pin Descriptions.

Rev. 0.5

July 22, 2015

· Initial release.



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